

<b>Notice of References Cited</b>	Application/Control No. 09/982,612	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
	Examiner Ajay M Bhatia	Art Unit 2145	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,519,636	02-2003	Engel et al.	709/223
	B	US-6,104,700	08-2000	Haddock et al.	370/235
	C	US-6,023,456	02-2000	Chapman et al.	370/252
	D	US-6,535,227	03-2003	Fox et al.	709/223
	E	US-6,789,203	09-2004	Belissent, Jacques E.	709/223
	F	US-6,801,503	10-2004	Wetherall et al.	709/226
	G	US-2002/0131366	09-2002	Sharp et al.	709/223
	H	US-2002/0143948	10-2002	Maher et al.	709/226
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.